
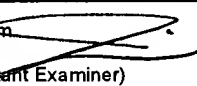
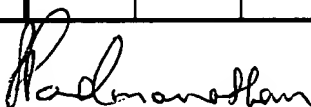
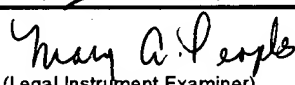


Issue Classification 	Application/Control No. 09845941	Applicant(s)/Patent under Reexamination HAYEK ET AL.
	Examiner: Kim, Jennifer	Art Unit: 1617

ISSUE CLASSIFICATION											
ORIGINAL						CROSS REFERENCE(S)					
CLASS		SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
514	558				514	560					
INTERNATIONAL CLASSIFICATION						424	442				
A	6	1	K	31	/ 20						
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Jennifer Kim  5/12/2005 (Assistant Examiner) (Date)						 SREENI PADMANABHAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date)					
 5/16/05 (Legal Instrument Examiner) (Date)						Total Claims Allowed: 6 O.G. Print Claim(s) 1 O.G. Print Flg. 0					

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